

One-Step Electrodeposition of CuZnSn Metal Alloy Precursor Film Followed by the Synthesis of Cu₂ZnSnS₄ and Cu₂ZnSnSe₄ Light Absorber Films and Heterojunction Devices

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CuZnSn metallic alloy precursor films were electrodeposited on Mo substrate from a Zn-rich bath solution yielding low deposition rates. The precursor films were converted to photovoltaic absorber films of Cu₂ZnSnS₄ and Cu₂ZnSnSe₄ by sulfurization and selenization processes. X-ray diffraction, Raman spectroscopy and photocurrent spectroscopy techniques were utilized for the identification of films. The surface morphology, uniformity and compactness of the films were examined by scanning electron microscopy. The precursor and absorber films had a uniform and compact structure. The precursor films were composed from the Cu₃Sn, Cu₆Sn₅ and Cu₅Zn₈ phases and their grain size varied tightly with the cathode potential. The conversion of precursor films to Cu₂ZnSnS₄ and Cu₂ZnSnSe₄ were verified from the results of their X-ray diffraction, Raman shifts, and optical transition energies. To assess the device quality of the absorber films, CdS/Cu₂ZnSnS₄ and CdS/Cu₂ZnSnSe₄ heterojunction diodes were fabricated and their device parameters were determined. The diodes showed relatively good ideality factor of 1.3-1.9, current rectification factor of ~120, and reverse biased saturation current of ~30-60 μA/cm². Photocurrent spectroscopy was utilized to evaluate the band gap energy and other optical transition energies of the absorber films from the short-circuit photocurrent of the diodes.

Keywords: CZTS; CZTSe; electrodeposition; photocurrent; Raman

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